Issue Classification

Application/Control No. 10532524	**Applicant(s)/Patent Under Reexamination** CHEN ET AL.
Examiner Emmanuel Bayard	**Art Unit** 2611

ORIGINAL		INTERNATIONAL CLASSIFICATION	
CLASS	SUBCLASS	CLAIMED	NON-CLAIMED
375	316	H 0 3 K 9 / 00 (2006.01.01)	

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375	316	340			

NONE	
(Assistant Examiner) (Date)	**Total Claims Allowed:** 28

/Emmanuel Bayard/	6/4/08	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner)	(Date)	1	6

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